

<b>Notice of References Cited</b>	Application/Control No. 10/823,469	Applicant(s)/Patent Under Reexamination NAIK ET AL.	
	Examiner Lan Nguyen	Art Unit 3683	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,345,191	08-1982	Takats et al.	318/564
	B	US-4,700,304	10-1987	Byrne et al.	701/76
	C	US-5,001,641	03-1991	Makino, Fumio	701/76
	D	US-5,136,704	08-1992	Danielsen et al.	714/11
	E	US-5,548,601	08-1996	Kato et al.	714/820
	F	US-5,627,867	05-1997	Thomson, David	377/16
	G	US-6,345,225	02-2002	Bohm et al.	701/70
	H	US-2003/0006726	01-2003	Weiberle et al.	318/370
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.